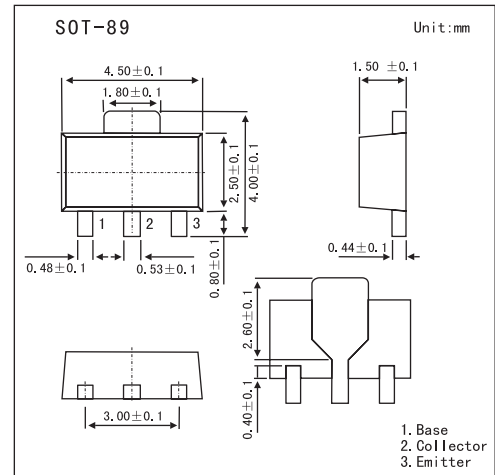


High-Voltage Switching Applications

2SC3649



■ Features

- Adoption of FBET, MBIT Processes
- High Breakdown Voltage and Large Current Capacity

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

| Parameter | Symbol | Rating | Unit |
|-----------------------------|-----------|-------------|------------------|
| Collector-Base Voltage | V_{CB0} | 180 | V |
| Collector-Emitter Voltage | V_{CE0} | 160 | V |
| Emitter-Base Voltage | V_{EB0} | 6 | V |
| Collector Current | I_C | 1.5 | A |
| Collector Current (Pulse) | I_{CP} | 2.5 | A |
| Collector Power Dissipation | P_C | 500 | mW |
| | P_C^* | 1.5 | W |
| Junction temperature | T_j | 150 | $^\circ\text{C}$ |
| Storage temperature Range | T_{stg} | -55 to +150 | $^\circ\text{C}$ |

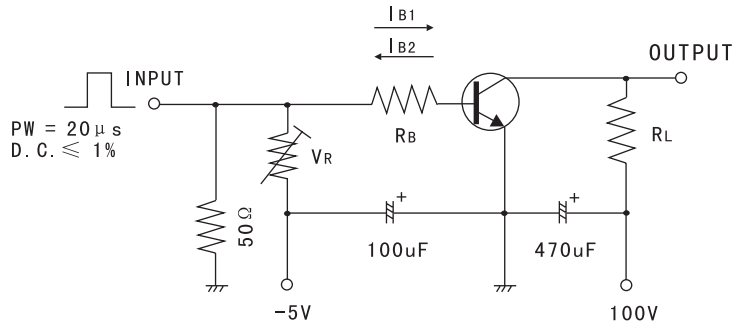
* Mounted on ceramic board (250 mm² x 0.8 mm)

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

| Parameter | Symbol | Testconditions | Min | Typ | Max | Unit |
|--------------------------------------|---------------|---|-----|------|------|---------------|
| Collector Cut-off Current | I_{CBO} | $V_{CB} = 120\text{V}$, $I_E = 0$ | | | 1 | μA |
| Emitter Cut-off Current | I_{EBO} | $V_{EB} = 4\text{V}$, $I_C = 0$ | | | 1 | μA |
| Collector-Base Breakdown Voltage | $V_{(BR)CBO}$ | $I_C = 10\mu\text{A}$, $I_E = 0$ | 180 | | | V |
| Collector-Emitter Breakdown Voltage | $V_{(BR)CEO}$ | $I_C = 1\text{mA}$, $R_{BE} = \infty$ | 160 | | | V |
| Emitter-Base Breakdown Voltage | $V_{(BR)EBO}$ | $I_E = 10\mu\text{A}$, $I_C = 0$ | 6 | | | V |
| DC Current Gain | h_{FE} | $V_{CE} = 5\text{V}$, $I_C = 100\text{mA}$ | 100 | | 400 | |
| | | $V_{CE} = 5\text{V}$, $I_C = 10\text{mA}$ | 80 | | | |
| Collector-Emitter Saturation Voltage | $V_{CE(sat)}$ | $I_C = 500\text{mA}$, $I_B = 50\text{mA}$ | | 0.13 | 0.45 | V |
| Base-Emitter Saturation Voltage | $V_{BE(sat)}$ | $I_C = 500\text{mA}$, $I_B = 50\text{mA}$ | | 0.85 | 1.2 | V |
| Gain-Bandwidth Product | f_T | $V_{CE} = 10\text{V}$, $I_C = 50\text{mA}$ | | 120 | | MHz |
| Collector Output Capacitance | C_{ob} | $V_{CB} = 10\text{V}$, $I_E = 0$, $f = 1\text{MHz}$ | | 14 | | pF |
| Turn-On Time | t_{on} | See Test Circuit. | | 40 | | ns |
| Storage Time | t_{stg} | | | 1.2 | | μs |
| Fall Time | t_f | | | 80 | | ns |

2SC3649

Test Circuit

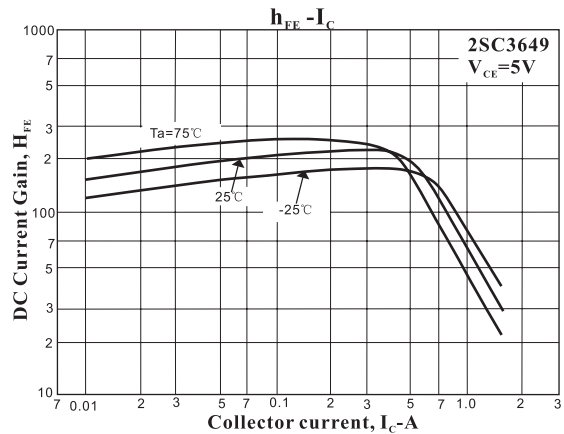
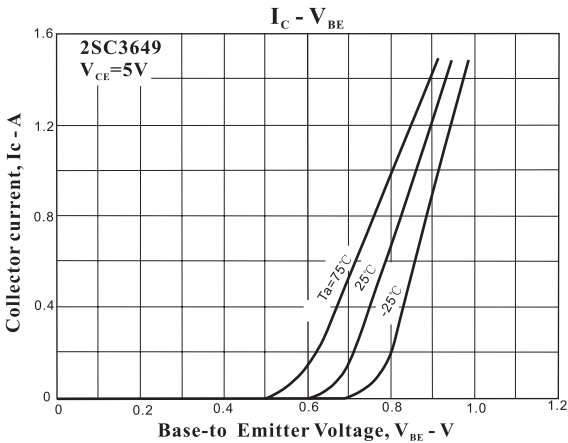
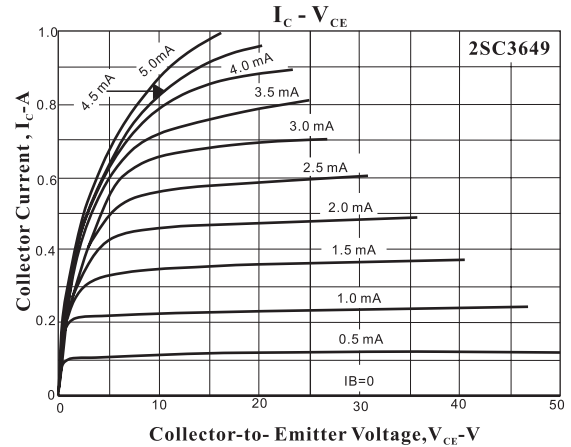
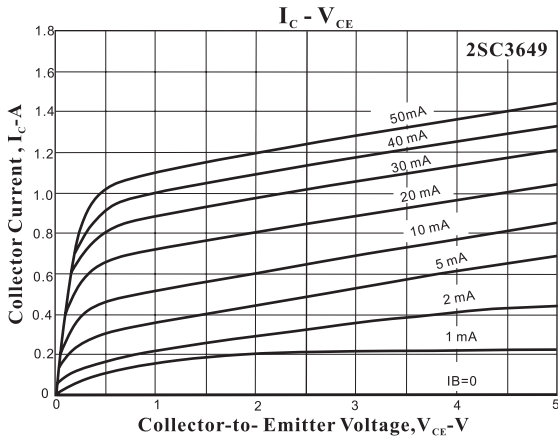


$10I_{B1} = -10I_{B2} = I_C = 0.7A$
 (For PNP, the polarity is reversed.)

hFE Classification

| Marking | CE | | |
|---------|-----------|-----------|-----------|
| | R | S | T |
| hFE | 100 ~ 200 | 140 ~ 280 | 200 ~ 400 |

Electrical Characteristics Curves



2SC3649

